

<b>Notice of References Cited</b>	Application/Control No. 10/824,562	Applicant(s)/Patent Under Reexamination TSUGITA ET AL.	
	Examiner Chia-Wei A. Chen	Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,075,569 B2	07-2006	Niikawa, Masahito	348/218.1
*	B	US-5,602,412	02-1997	Suzuki et al.	257/432
*	C	US-2002/0071041 A1	06-2002	Pine, Joshua I.	348/222
*	D	US-7,236,190 B2	06-2007	Yanof et al.	348/222.1
*	E	US-2004/0064019 A1	04-2004	Chang et al.	600/180
*	F	US-7,233,352 B2	06-2007	Matherson et al.	348/251
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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